

**Issue Classification**

Devin Hanan 3/5/2006  
(Assistant Examiner) (Date)

*Edward K. Look* 3/6/06  
**EDWARD K. LOOK**  
**SUPERVISORY PATENT EXAMINER**  
**TECHNOLOGY CENTER 3700**  
 (Primary Examiner) (Date)

<b>Total Claims Allowed: 11</b>	
O.G. Print Claim(s)	O.G. Print Fig.
<b>4</b>	<b>1</b>

☐ Claims renumbered in the same order as presented by applicant☐ CPA

☐ T.D.

☐ R.1.47

[illegible]